

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

With the principle of "Quality Parts, Customers Priority, Honest Operation, and Considerate Service", our business mainly focus on the distribution of electronic components. Line cards we deal with include Microchip, ALPS, ROHM, Xilinx, Pulse, ON, Everlight and Freescale. Main products comprise IC, Modules, Potentiometer, IC Socket, Relay, Connector. Our parts cover such applications as commercial, industrial, and automotives areas.

We are looking forward to setting up business relationship with you and hope to provide you with the best service and solution. Let us make a better world for our industry!



Contact us

Tel: +86-755-8981 8866 Fax: +86-755-8427 6832

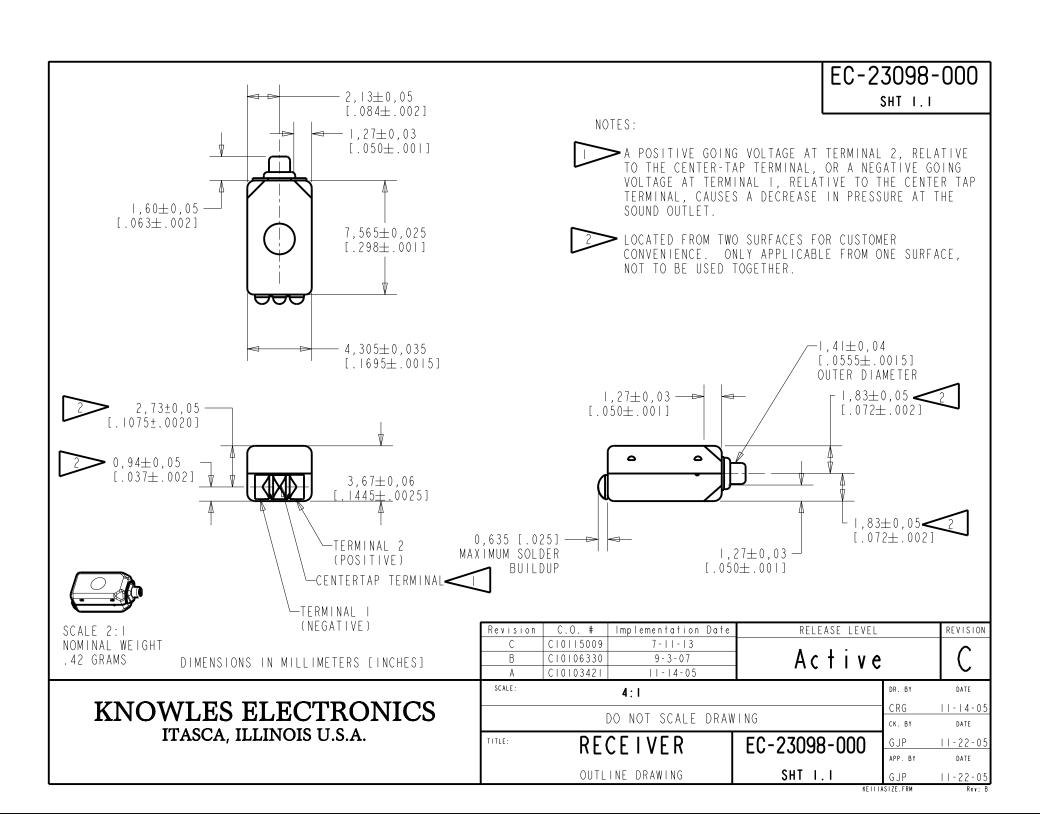
Email & Skype: info@chipsmall.com Web: www.chipsmall.com

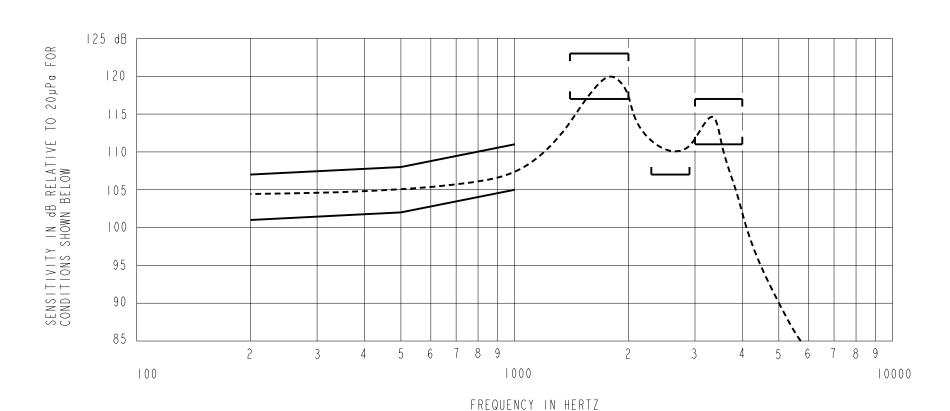
Address: A1208, Overseas Decoration Building, #122 Zhenhua RD., Futian, Shenzhen, China











NOTES:

- I. MEASUREMENTS MADE USING 10mm (.394") OF 1mm (.039") ID TUBE CONNECTED TO A SIMULATED ANSI S3.7 TYPE HA-3 COUPLER. (IEC 60318-5).
- 2. SENSITIVITY

FREQUENCY	MIN.	MAX.
200 500 1000 1400-2000 2300-2900 3000-4000	101.0 102.0 105.0 117.0 107.0	107.0 108.0 111.0 123.0

- 3. RESPONSE, IMPEDANCE, AND DISTORTION MEASUREMENTS MADE USING THE ELECTRICAL TEST CONDITIONS SHOWN BELOW.
- 4. ELECTRICAL SOURCE IMPEDANCE MUST BE GREATER THAN 20 TIMES IKHZ IMPEDANCE FOR TEST CONDITIONS SHOWN BELOW.
- 5. INDIVIDUAL SPECIFICATIONS:

PORT	IMPEDANCE OHMS ±15%		DCR @20°C	DISTORTION		ELECTRICAL TEST CONDITIONS	
LOCATION	IKHz	500Hz	OHMS 土IO%	MAX. %	FREQ Hz	AC mA RMS	DC mA
128	840	425	196	10	800	0.77	0.00

Revision	C.O. #	Implementation Date	RELEASE LEVEL	REVISION
С	C10115009	7 - 1 1 - 1 3		\sim
В	C10106330	9 - 3 - 0 7	Active	(
Α	C10103421	11-14-05	114 1 1 4)

11-14-05

DATE

11-22-05

11-22-05

KNOWLES ELECTRONICS ITASCA, ILLINOIS U.S.A.

WHEN TEST LIMITS ARE USED TO ESTABLISH INCOMING INSPECTION ACCEPTANCE/REJECTION CRITERIA, CORRELATION OF TEST EQUIPMENT WITH KNOWLES IS ALSO REQUIRED FOR		DR. BY
ELIMINATION OF EQUIPMENT AND TEST METHOD VARIATION		CK. BY
TITLE: RFCFIVFR	EC-23098-000	GJP
		APP BY